

SJTD08N65C

s

Super-Junction MOSFET

Applications:

- Adaptor
- Charger
- .SMPS

Features:

- RoHS Compliant
- . Low ON Resistance
- . Low Gate Charge
- Peak Current vs Pulse Width Curve
- Inductive Switching Curves

Ordering Information

| PART NUMBER | PACKAGE | BRAND |
|-------------|---------|-------|
| SJTD08N65C | TO-252 | IPS |

Absolute Maximum Ratings

$T_C=25^{\circ}C$ unless otherwise specified

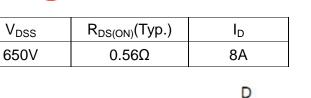
G

Pb)

| Symbol | Parameter | SJTD08N65C | Units |
|-------------------------------|---|----------------|-------|
| V _{DSS} | Drain-to-Source Voltage | 650 | V |
| I _D | Continuous Drain Current | 8 | А |
| I _{DM} | Pulsed Drain Current, V _{GS} @10V (NOTE *2) | 24 | А |
| D | Power Dissipation | 63 | W |
| P _D | Derating Factor above 25°C | 0.5 | W/℃ |
| V _{GS} | Gate-to-Source Voltage | ±30 | V |
| E _{AS} | Single Pulse Avalanche Energy | 162 | mJ |
| E _{AR} | Avalanche Energy ,Repetitive (NOTE *2) | 0.2 | mJ |
| I _{AR} | Avalanche Current (NOTE *2) | 1.4 | Α |
| T∟ | Maximum Temperature for Soldering | 300 | |
| $T_{\rm J}$ and $T_{\rm STG}$ | Operating Junction and Storage Temperature Range (NOTE *1) | 150, -55 to150 | °C |

Thermal Resistance

| Symbol | Parameter | Тур. | Units | Test Conditions |
|-----------------------|---------------------|------|--------------|---|
| Б | Junction-to-Case | 2 | | Water cooled heatsink, P_{D} adjusted for a |
| $R_{	extsf{	heta}JC}$ | Junction-to-Case | 2 | °C /W | peak junction temperature of +150°C. |
| R _{0JA} | Junction-to-Ambient | 62 | | 1 cubic foot chamber, free air. |



TO-252

Packages Not to Scale

Lead Free Package and Finish



| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|-------------------|-----------------------------------|------|------|------|-------|--|
| BV _{DSS} | Drain-to-Source Breakdown Voltage | 650 | | | V | V _{GS} =0V, I _D =250µA |
| I _{DSS} | Drain-to-Source Leakage Current | | | 1 | μA | V _{DS} =650V, V _{GS} =0V T _J =25℃ |
| | | | | 100 | | V _{DS} =650V, V _{GS} =0V T _J =150℃ |
| I _{GSS} | Gate-to-Source Forward Leakage | | | +100 | n A | V_{GS} =+30V |
| | Gate-to-Source Reverse Leakage | | | -100 | nA | V _{GS} = -30V |

OFF Characteristics $T_C=25^{\circ}C$ unless otherwise specified

ON Characteristics T_J=25°C unless otherwise specified

| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|------------------------|-----------------------------------|------|------|------|-------|---|
| R _{DS(ON)} | StaticDrain-to-Source | | | | | V _{GS} =10V, I _D =3A |
| | On-Resistance(NOTE *3) | | 0.56 | 0.62 | Ω | |
| V _{GS(TH)} | Gate Threshold Voltage | 2.5 | | 4 | V | V _{DS} =V _{GS} ,I _D =250µA |
| g _{fs} | Forward Transconductance(NOTE *3) | | 5 | | S | V _{DS} =10V, I _D =3A |

Dynamic Characteristics Essentially independent of operating temperature

| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|------------------|---------------------------------|------|------|------|-------|---|
| C _{iss} | Input Capacitance | | 587 | | pF | V_{GS} = 0V, V_{DS} = 50V f =1.0MHz |
| C _{oss} | Output Capacitance | | 31 | | | |
| C _{rss} | Reverse Transfer Capacitance | | 4 | | | |
| Qg | Total Gate Charge | | 14.5 | | nC | I _D =7A,V _{DD} =520V V _{GS} = 10V |
| Q _{gs} | Gate-to-Source Charge | | 3 | | | |
| Q _{gd} | Gate-to-Drain ("Miller") Charge | | 5.2 | | | |

Resistive Switching Characteristics Essentially independent of operating temperature

| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|---------------------|---------------------|------|------|------|-------|---|
| t _{d(ON)} | Turn-on Delay Time | | 39 | | ns | V _{DD} =400V, I _D =7A, V _G =10V R _G =25Ω |
| t _{rise} | Rise Time | | 25 | | | |
| t _{d(OFF)} | Turn-Off Delay Time | | 100 | | | |
| t _{fall} | Fall Time | | 18 | | | |



| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|-----------------|---------------------------|------|------|------|-------|---------------------------------|
| l _S | Continuous Source Current | | | 6.3 | А | T _C =25℃ |
| | (Body Diode) | | | | | |
| I _{SM} | Maximum Pulsed Current | | | 19 | A | |
| | (Body Diode) | | | | | |
| V _{SD} | Diode Forward Voltage | | | 1.2 | V | I_{SD} =7A, V_{GS} =0V |
| t _{rr} | Reverse Recovery Time | | 250 | | ns | I _F = I _S |
| Q _{rr} | Reverse Recovery Charge | | 2.1 | | uC | di/dt=100A/us |

Source-Drain Diode Characteristics Tc=25°C unless otherwise specified

Notes:

*1. Repetitive rating; pulse width limited by maximum junction temperature.

*2. I_{AS} =1.4A,V $_{DD}$ =50V, Start T_{J} =25 $^{\circ}\mathrm{C}$

*3. I_{SD} =8A,di/dt ≤100A/us,V_{DD}≤BV_{DS}, Start T_J=25 $^\circ\!\!\mathbb{C}$



Characteristics Curve:

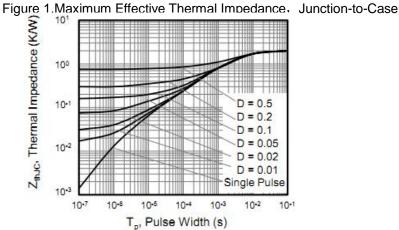


Figure 2. Typical Output Characteristics

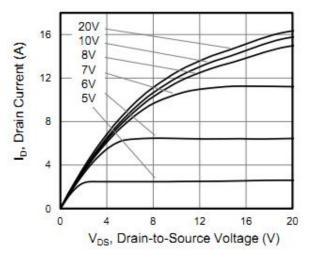


Figure 4. Typical Body Diode Transfer Characteristics

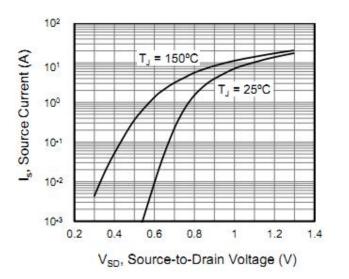


Figure 3. Typical Transfer Characteristics

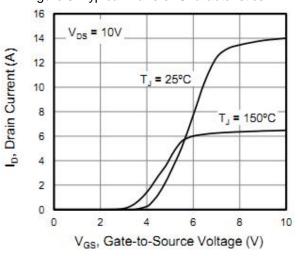
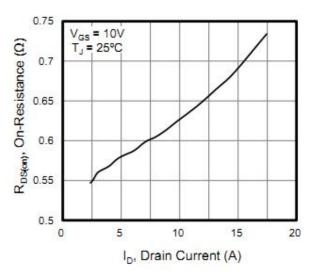


Figure 5. Typical Drain-to-source on ResistanceVS Drain Current

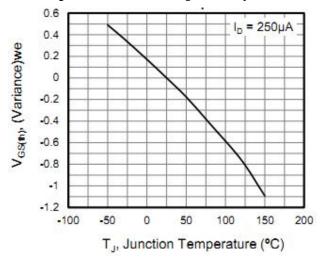




104 Ciss Capacitance (pF) 10³ 10² Cqss 101 Crss $V_{GS} = 0$ 1MHz 100 20 30 0 10 40 50 60 V_{DS}, Drain-to-Source Voltage (V)

Figure 6. Capacitance VS Drain-to-Source Voltage





 (λ) and (λ)

Figure 9. on-Resistance VS Temperature

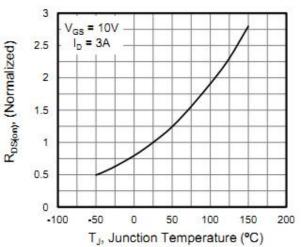
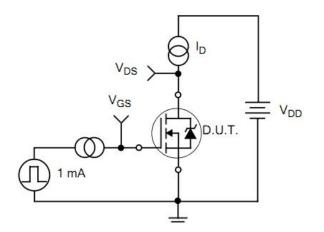


Figure 7. Gate Charge VS Gate-to-Source Voltage



Test Circuits and Waveforms



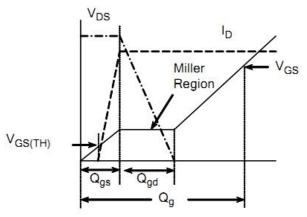
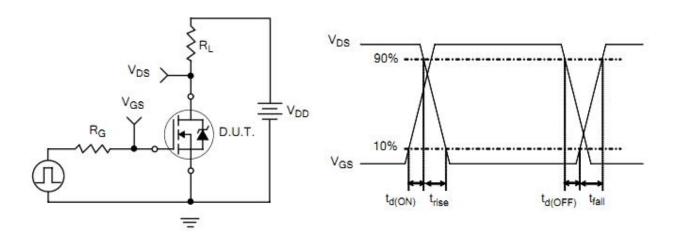
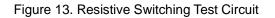
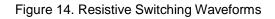


Figure 11. Gate Charge Test Circuit

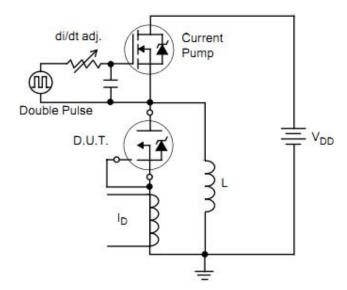
Figure 12. Gate Charge Waveforms











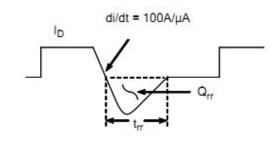


Figure 15. Diode Reverse Recovery Test Circuit

Figure 16. Diode Reverse Recovery Waveform

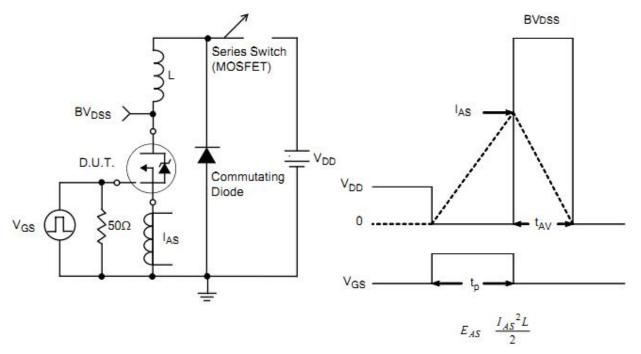


Figure 17. Unclamped Inductive Switching Test Circuit Figure 18. Unclamped Inductive Switching Waveform



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